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# Single Electron Transistor Scheme Based on Multiple Quantum Dot Islands: Carbon Nanotube and Fullerene

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## Abstract

Single electron transistor (SET) is a nano dimension device that is offered by technology to solve the problem of aggressive scaling in traditional transistors. Its operation speed depends on carrier mobility of its quantum dot. In this research, fullerene ( $C_{60}$ ) and carbon nanotube (CNT) are utilized as materials of quantum dots in SET. Two SETs with different multiple quantum dots as  $C_{60}$ -CNT- $C_{60}$  and CNT- $C_{60}$ -CNT are modeled and analyzed. The comparison study shows that total length of quantum dots as fullerene diameter and CNT length have indirect effect on its current. Moreover increasing temperature decreases its current while rising of the gate voltage increases its current. In other words, quantum dot length, temperature and gate voltage are parameters which can control SET operation. Furthermore two SETs are simulated and their stability diagrams are analyzed. The simulation results show that  $C_{60}$ -CNT- $C_{60}$  SET has lower coulomb blockade and also it has more reliability and faster operation than CNT- $C_{60}$ -CNT SET.

**Key words:** Carbon Nanotube, Fullerene, Quantum Dot, Single Electron Transistor.

## 1-Introduction

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According to the Moore's law, the number of transistors in a chip is doubled every 2-3 years but MOSFET scaling results in performance degradations generally called short channel effects (SCEs). Novel transistors are designed to improve limitations imposed by SCEs in traditional bulk MOSFETs. Common examples which are used by the industry includes FinFETs, tunnel FETs, and nanowires FETs [1,2,3]. However, all these technologies still suffer from leakage current and power consumption. On the other hand, we know electrons cross from the transistor channel, so decreasing the number of electrons and transfer one electron from transistor channel at a very short time can improve its performance and increase its operation speed. Furthermore advanced electronic technology needs chips capable of doing more information processing in a shorter time compared with traditional chips and scaling according to Moore's law is no more adequate to achieve nano-dimension devices based on transfer of many carriers at the same time. The device which can improve these limitations in nanoscale is single electron transistor (SET). SET with its particular characteristics such as low energy consumption, nano size dimension and high operating speed can be a candidate to continue aggressive scaling [4]. SET works based on the transfer of single electrons in its channel in a very short time, so its operation speed is much higher than traditional MOSFETs and their derivatives. SET contains source and drain electrodes, gate electrode and an island between them. Its gate electrode can control electron tunneling. SET operates by moving an electron via tunneling between source and drain electrodes [5]. It has higher speed operation and lower energy consumption than Field Effect Transistors (FETs) [6, 7]. FETs work by crossing some electrons in their channels but SET operates by transfer of single electrons between electrodes and island through a tunnel Junction [8,9,10]. Any tunnel junction consists of one capacitance and a resistance in series [11]. When an electron crosses from a tunnel junction to island, the capacitor charges and tunneling of second electron is stopped [12]. This electron is transferred to the other electrode and this phenomenon is called single electron tunneling [13].

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Another phenomenon is Coulomb Blockade (CB) that affects on SET operation which has been discussed by C. Gorter in 1951 [14, 15]. It occurs when the resistance of a tunnel junction becomes more than quantum resistance [16]. It prevents electron transfer to or out of SET island, so operation speed of SET depends on carrier mobility in the island [17]. On the other hand, the island has high carrier mobility in quantum size. Therefore quantum dot (QD) can be used in transistor nanostructure [18, 19]. Moreover increasing the number of QDs can

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reduce some operation limitations of SET such as cryogenic temperature and leakage current [20]. Increasing cryogenic temperature to room temperature is a good improvement in SET operation because CB occurs when the charging energy is less than the thermal energy (The essential energy to tunnel an electron to the QD) [21, 22]. The coulomb blockade interval makes a diamond-shaped region which is called coulomb diamond. It is function of  $V_g$  and  $V_{ds}$  while the number of electrons on the QD are fixed in any region. The curve for  $V_g$  versus  $V_{ds}$  is called charge stability diagram [23]. Furthermore, material of QD has direct effect on SET operation. There are different QDs but carbon based materials such as fullerenes and carbon nanotube (CNT) have higher carrier mobilities than other materials [12,24]. Hence, fullerene SET presents lower leakage current and CB region compared with silicon QD-SET [22]. CNT is a one dimensional material while Fullerene is classified under category of zero dimensional materials [25, 16]. Fullerenes have different natural forms as  $C_{38}$  and  $C_{42}$ . In addition, some molecules have several symmetric shapes that make direct influence on SET operation [26]. This effect is investigated for three molecules  $C_{38}$ ,  $C_{42}$  and  $C_{60}$  as shown in Fig.1 and then their charge stability diagrams are reported in Fig.2 (a-f) [27]. The comparison study in Fig.2 indicates that  $C_{38}$  and  $C_{42}$  have different stability diagrams because they exhibit different types of symmetry. This problem decreases reliability of SET, so buckminster fullerene ( $C_{60}$ ) is selected as SET island. Its molecule not only has one type of symmetry but also is cheaper to produce compared with other fullerene molecules while it is very stable in nano range dimensions [28].

SETs can be used in quantum computing, single electron memory and supersensitive electrometry. In this research, the advantages of two proposed SET structured are explored utilizing fullerene and CNT. Because of SET unique characteristics, it can be an alternative for the next generation of devices in electronic circuits. Moreover we investigate the impact of fullerene diameter, CNT length, temperature and the gate voltage on the SET performance. Finally a comparison study is performed between two proposed structures to reveal which one can be a suitable candidate for replacement of traditional transistors in future technology.

## 2-Theoretical Model

Single electron transistor works based on electron tunneling from source electrode to drain electrode. This electron transfer can be analyzed by the quantum mechanical effects describing that when electron wave crosses from different regions of the device, it has a particular wave function in each region. Therefore SET islands, drain and source are different

target regions as shown in Fig. 3 where Schrodinger's equations can be written for them. The SET model is based on three islands that each island is assumed to behave like a potential well. Equations which explain wave function at regions of a fullerene island are:

$$\Psi_I = A_1 e^{k_1 x} + B_1 e^{-k_1 x} \quad (1) \quad 99$$

$$\Psi_{II} = A_2 e^{ik_2 x} + B_2 e^{-ik_2 x} \quad (2) \quad 100$$

$$\Psi_{III} = A_3 e^{ik_3 x} \quad (3) \quad 101$$

where  $k_1 = k_3 = \frac{\sqrt{2m(V_0-E)}}{\hbar}$  and  $k_2 = \frac{\sqrt{2mE}}{\hbar}$ . 102

These equations can be solved using appropriate boundary conditions which can be written from continuity of the wave function and its derivative at  $x = 0$  and  $L_1$ . These parts of the modeling are fully covered at the appendix A. 103  
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Therefore transmission coefficient of region with a fullerene island is calculated as: 106

$$T_1 = \frac{1}{1 + K_F \sinh^2(k_2 L_1)} \quad (4) \quad 107$$

$$K_F = \frac{(\hbar^2 + ta'm)E - \hbar^2 E_{g_F}}{2 \sqrt{ta' \hbar m E (E - E_{g_F})}} \quad (5) \quad 108$$

where " $L_1$ " is fullerene diameter,  $k_2 = \frac{\sqrt{2mE}}{\hbar}$ , " $E$ " is the electron energy, " $m = 9.109 \times 10^{-31} kg$ " is the electron effective mass in fullerene, " $\hbar = 6.582119514 \times 10^{-16} eV.s$ " is the reduced Planck's constant, " $a' = 3a_{c-c}$ ",  $a_{c-c_F} = 1.46A^0$  is the distance between neighbouring carbon atoms in fullerene molecule, " $E_{g_F} = 0.1828$ " is the fullerene bandgap ( $C_{60}$  energy gap is defined as the difference between the highest occupied and lowest unoccupied molecular orbitals (HOMO and LUMO)) and " $t=2.5eV$ " is the hopping energy. 109  
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The Shorodinger equations are written for second part of SET with carbon nanotube island as: 115  
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$$\Psi_{III} = A_3 e^{k_1 x} + B_3 e^{-k_1 x} \quad (6) \quad 117$$

$$\Psi_{IV} = A_4 e^{ik_4 x} + B_4 e^{-ik_4 x} \quad (7) \quad 118$$

$$\Psi_V = A_5 e^{ik_1 x} \quad (8) \quad 119$$

where  $k_1 = \frac{\sqrt{2m(V_0-E)}}{\hbar}$  and  $k_4 = \frac{\sqrt{2mE}}{\hbar}$ . 120

These set of equations should also be solved and the boundary conditions can be written at points  $x = 0$  and  $L_2$ . These parts of model are also fully covered at the appendix A. 121  
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Therefore transition coefficient of region with a CNT island is calculated as 123

$$T_2 = \frac{1}{1+K_{CNT} \sinh^2(k_4 L_2)} \quad (9) \quad 124$$

$$K_{CNT} = \frac{(\hbar^2 + t a' m) E - \hbar^2 E_{g_{CNT}}}{2 \sqrt{t a' \hbar m E (E - E_{g_{CNT}})}} \quad (10) \quad 125$$

where " $L_2$ " is the CNT length,  $k_4 = \frac{\sqrt{2mE}}{\hbar}$ ,  $a_{c-c_{CNT}} = 1.42A^0$  is the distance between neighbouring carbon atoms, " $E_{g_{CNT}} = \frac{0.8eV}{d(nm)}$ " is the CNT band gap where  $d = 2R$  is the CNT diameter and " $t=2.7eV$ " is the hopping energy of CNT. 126  
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The first proposed SET comprises three islands as two fullerene molecules and one CNT. 129

Therefore the product of three calculated transmission coefficients as obtained in Eqs. (4) and 130

(9) results in the total transmission coefficient as: 131

$$T_{Total_1} = T_1 \times T_2 \times T_1 \quad (11) \quad 132$$

$$T_{Total_1} = \frac{1}{K_F^4 k_2^4 L_1^4 + 1 + 2K_F^2 k_2^2 L_1^2 + K_{CNT}^4 K_F^2 k_2^4 k_4^2 L_1 L_2 + K_{CNT}^4 k_4^2 L_2^2 + 2K_F^2 K_{CNT}^2 k_2^2 k_4^2 L_1^2 L_2^2} \quad (12) \quad 133$$

where " $L_1$ " is diameter of fullerene and " $L_2$ " is CNT length. The parameters were defined previously. 134  
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SET current with three multiple islands as two fullerene molecules and one CNT can be calculated based on the Landauer formalism as: 136  
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$$I = \int_0^\eta T(E) \cdot F(E) dE \quad (13) \quad 138$$

where "T(E)" is the total transmission coefficient of SET ( $T_{total_1}$ ) and F(E) is Fermi 139

probability function defined as  $F(E) = \left[ \frac{1}{\exp\left(\frac{E-E_F}{k_B T}\right) + 1} \right]$ , where "E" is electron energy, " $E_F$ " is 140

Fermi energy, "T" is temperature and " $k_B$ " presents the Boltzmann's constant. 141

Based on proposed model, the current versus voltage characteristic of the SET with three 142

islands as two fullerene molecules and one CNT in the parabolic-band region can be 143

expressed as: 144

$$I = \int_0^\eta \frac{1}{K_F^4 (A k_B T (x+d_F))^2 L_1^4 + 1 + 2K_F^2 (A k_B T (x+d_F)) L_1^2 + K_{CNT}^4 K_F^2 (A k_B T (x+d_F))^2 (A k_B T (x+d_{CNT})) L_1 L_2 + K_{CNT}^4 (A k_B T (x+d_{CNT})) L_2^2 + 2K_F^2 K_{CNT}^2 (A k_B T (x+d_F)) (A k_B T (x+d_{CNT})) L_1^2 L_2^2} \frac{dE}{e^{x-\eta} + 1}} \quad (14) \quad 145$$

where " $L_1$ " is diameter of fullerene and " $L_2$ " is length of CNT,  $x = \frac{E-E_g}{k_B T}$ ,  $\eta = \frac{E_F-E_g}{k_B T}$ ,  $E_g =$  146

$\frac{E_g + E_{g_{CNT}}}{2}$ ,  $d_F = \frac{E_g}{k_B T}$ ,  $d_{CNT} = \frac{E_{g_{CNT}}}{k_B T}$ ,  $A = \sqrt{\frac{2m}{\hbar^2}}$  and other parameters were defined previously. 147

The second proposed SET comprises three islands as two CNTs and one fullerene molecule. 148  
The product of three transmission coefficients as calculated in Equations (4) and (9) will be 149  
total transmission coefficient which is now given by: 150

$$T_{Total_2} = T_2 \times T_1 \times T_2 \quad (15) \quad 151$$

$$T_{Total_2} = \frac{1}{K_{CNT}^4 k_4^4 L_2^4 + 1 + 2K_{CNT}^2 k_4^2 L_2^2 + K_F^4 K_{CNT}^2 k_4^2 k_2^2 L_2 L_1 + K_F^4 k_2^2 L_1^2 + 2K_{CNT}^2 K_F^2 k_4^2 k_2^2 L_2^2 L_1^2} \quad (16) \quad 152$$

where all of the parameters in Eq. (16) were previously defined. Therefore the SET current 153  
with three multiple islands as one fullerene molecule and two CNTs can be calculated based 154  
on the Landauer formalism as: 155

$$I = \int_0^\eta \frac{1}{K_{CNT}^4 (A_{k_B T}(x+d_{CNT}))^2 L_2^4 + 1 + 2K_{CNT}^2 (A_{k_B T}(x+d_{CNT})) L_2^2 + K_F^4 K_{CNT}^2 (A_{k_B T}(x+d_{CNT}))^2 (A_{k_B T}(x+d_F)) L_1 L_2} \frac{dE}{+K_F^4 (A_{k_B T}(x+d_F)) L_1^2 + 2K_F^2 K_{CNT}^2 (A_{k_B T}(x+d_{CNT})) (A_{k_B T}(x+d_F)) L_1^2 L_2^2 e^{x-\eta} + 1}} \quad (17) \quad 156$$

where all parameters were defined previously. 157

### 3- Results and discussion 158

The proposed models depend on some parameters such as temperature, island length and gate 159  
voltage. The impact of CNT length on the current in the first proposed SET is investigated 160  
and plotted in Fig. 4. The gate voltage is 1mV, temperature is 300<sup>0</sup> K and the fullerene 161  
diameter is 1nm. The variations in Fig. 4 indicates that CNT length has an indirect effect on 162  
the SET current because increasing CNT length increases distance between source and drain 163  
therefore leakage current increases in SET .This SET contains two fullerene molecules where 164  
the effect of their diameters on the current is shown in Fig. 5. The gate voltage is 1mV, 165  
temperature is 300<sup>0</sup> K and CNT length is 1nm. Fig. 5 shows that decreasing of fullerene 166  
diameter decreases leakage current, so it increase SET current. Another effective factor in the 167  
proposed model is the temperature. The impact of temperature on the SET I-V characteristics 168  
is illustrated in Fig. 6. Here the gate voltage is chosen as 1mv, CNT length and fullerene 169  
diameter are both 1nm. It can be seen that the temperature has indirect effect on the proposed 170  
model. The increasing temperature increases electron tunneling to QD but electron 171  
accumulation occurs in QD, so electron transfer decreases and current decreases in higher 172  
temperature. Moreover effect of the gate voltage on SET current is investigated and sketched 173  
in Fig. 7. The temperature is 300<sup>0</sup> K, CNT length and fullerene diameter are both 1nm. The 174  
curves in Fig. 7 show that increasing of the applied gate voltage increases SET current. 175

The next proposed SET for our study is comprised of three islands: two CNTs in the channel 176  
sides and one fullerene molecule in the middle as shown in Fig. 8. 177

The current versus voltage characteristic of the second proposed SET with one fullerene molecule in the channel and two carbon nanotubes on its sides depends on some factors. The island length affects on SET current. Impact of the CNT length on SET current is investigated as shown in Fig. 9. The gate voltage is 1mV, temperature is 300<sup>0</sup> K and fullerene diameter is 1nm. It confirms that the CNT length has indirect effect on the SET current. The impact of fullerene molecule diameter on the SET current is plotted in Fig. 10. Here, the gate voltage is assumed to be 1mV, temperature is 300<sup>0</sup> K and CNT length is 1nm. It confirms that increasing fullerene diameter decreases SET current as expected. Both Fig .9 and Fig .10 show the bigger QD has the more leakage current, so lower SET current occurs in this case. Moreover the current is affected by changing the temperature as illustrated in Fig. 11. Again, the gate voltage is 1mv, CNT length and fullerene diameter are both 1nm. It reveals the fact that increasing of the temperature decreases SET current that shows electron accumulation in QDs and decreasing current. Another important factor is the gate voltage as plotted in Fig. 12. The temperature is 300<sup>0</sup> K, CNT length is 1nm and fullerene diameter is 1nm. The current versus voltage characteristics of different gate voltages in Fig. 12 show this factor has direct influence on the SET current.

The impact of island material on the SET operation can be illustrated using its charge stability diagram. Two proposed SETs with different islands  $C_{60} - CNT - C_{60}$  and  $CNT - C_{60} - CNT$  are designed with Atomistic Toolkit software [27], so their charge stability diagrams are simulated and plotted in Fig. 13. The important parameters which are extracted from stability diagrams of two structures as shown in Fig. 13 are summarized in table1. It clearly shows the range of gate and drain voltage for each diamond and the associated area. The sum of coulomb diamond areas for  $C_{60}$ -CNT- $C_{60}$  SET is 1.329 while this summation for CNT- $C_{60}$ - CNT SET equals 7.538.

Table1: Important parameters extracted from Fig. 13.

Diamond	$V_{ds_{min}}, V_{ds_{max}}$	$\Delta V_{ds}$	$V_{g_{min}}, V_{g_{max}}$	$\Delta V_g$	Area
$C_{60}$ -CNT- $C_{60}$	-0.297,0.319	0.616	-1.164,-0.869	2.033	0.626
Diamond 1					
$C_{60}$ -CNT- $C_{60}$	-0.312,0.319	0.631	-0.862,-0.529	1.391	0.438



Diamond 2					
$C_{60}$ -CNT- $C_{60}$	-0.529,-0.204	0.733	-0.521,-0.204	0.725	0.265
Diamond 3					
CNT- $C_{60}$ - CNT	-0.372,0.364	0.736	-3.159,-2.781	5.940	2.185
Diamond 1					
CNT- $C_{60}$ - CNT	-0.595,0.572	1.167	-2.773,-2.192	4.965	2.897
Diamond 2					
CNT- $C_{60}$ - CNT	-0.669,0.651	1.320	-2.182,-1.540	3.722	2.456
Diamond 3					

The comparison study of coulomb diamond patterns in Fig. 13 indicates that not only SET with two fullerene molecules and one CNT has smaller coulomb diamonds but also has lower coulomb blockade range and zero conductance region than other proposed SET. It reveals the fact that the most important factor in SET operation is the island length and since SET with  $C_{60} - CNT - C_{60}$  islands has smaller islands, it presents lower coulomb blockade range and faster and better operation compared with  $CNT - C_{60} - CNT$  SET.

#### 4-Conclusion

Single electron transistor (SET) based on quantum dot can improve problems of integrated circuit scaling. Quantum dots such as fullerene and carbon nanotube can be utilized to increase operation speed of SET. In this research, two SETs with fullerene ( $C_{60}$ ) and CNT islands as  $C_{60} - CNT - C_{60}$  SET and  $CNT - C_{60} - CNT$  SET were analyzed and also some effective factors on SET operation were investigated. The comparison study indicates that decreasing fullerene diameter, CNT length and temperature increase SET current but applied gate voltage has a direct effect on the current. Moreover proposed SETs were simulated and simulation results were compared together. Comparison study showed that  $C_{60} - CNT - C_{60}$  SET has lower coulomb blockade range and also higher operation speed than  $CNT - C_{60} - CNT$  SET. It confirms effective role of island length and its material in SET operation and

SET reliability. Therefore selecting suitable material for the island and the associated length can control the current value. Furthermore current can be tuned by temperature and applied gate voltage.

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## Appendix A

The Schrodinger equations are solved for the first part:

$$\frac{\hbar^2}{2m} \frac{d^2\psi_I(x)}{dx^2} + (E - V)\psi_I(x) = 0 \quad x \leq 0 \quad \text{Region I} \quad (\text{A1})$$

$$\frac{\hbar^2}{2m} \frac{d^2\psi_{II}(x)}{dx^2} + E\psi_{II}(x) = 0 \quad 0 < x < L_1 \quad \text{Region II} \quad (\text{A2})$$

$$\frac{\hbar^2}{2m} \frac{d^2\psi_{III}(x)}{dx^2} + (E - V)\psi_{III}(x) = 0 \quad x \geq L_1 \quad \text{Region III} \quad (\text{A3})$$

The boundary conditions can be written from continuity of the wave function and its derivative at  $x = 0$  and  $L_1$  as:

$$A_1 + B_1 = A_2 + B_2 \quad (\text{A4})$$

$$k_1A_1 - k_1B_1 = ik_2A_2 - ik_2B_2 \quad (\text{A5})$$

$$A_2e^{ik_2L_1} + B_2e^{-ik_2L_1} = A_3e^{k_1L_1} \quad (\text{A6})$$

$$ik_2A_2e^{ik_2L_1} - ik_2B_2e^{-ik_2L_1} = k_1A_3e^{k_1L_1} \quad (\text{A7})$$

The Schrodinger equations are solved for second part as:

$$\frac{\hbar^2}{2m} \frac{d^2\psi_{III}(x)}{dx^2} + (E - V)\psi_{III}(x) = 0 \quad x \leq 0 \quad \text{Region III} \quad (\text{A8})$$

$$\frac{\hbar^2}{2m} \frac{d^2\psi_{IV}(x)}{dx^2} + E\psi_{IV}(x) = 0 \quad 0 < x < L_2 \quad \text{Region IV} \quad (\text{A9})$$

$$\frac{\hbar^2}{2m} \frac{d^2\psi_V(x)}{dx^2} + (E - V)\psi_V(x) = 0 \quad x \geq L_2 \quad \text{Region V} \quad (\text{A10})$$

These boundary conditions can be written at  $x = 0$  and  $L_2$  as:

$$A_3 + B_3 = A_4 + B_4 \quad (\text{A11}) \quad 251$$

$$k_1 A_3 - k_1 B_3 = ik_2 A_4 - ik_2 B_4 \quad (\text{A12}) \quad 252$$

$$A_4 e^{ik_4 L_2} + B_4 e^{-ik_4 L_2} = A_5 e^{k_4 L_2} \quad (\text{A13}) \quad 253$$

$$ik_4 A_4 e^{ik_4 L_2} - ik_4 B_4 e^{-ik_4 L_2} = k_1 A_5 e^{k_4 L_2} \quad (\text{A14}) \quad 254$$

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## References

256

257

[1] M.Saremi, A. Afzali-Kusha and S. Mohammadi, "Ground plane fin-shaped field effect transistor (GP-FinFET): a FinFET for low leakage power circuits", *Microelectronic Engineering*, vol. 95, pp. 74-82, 2012. 258  
259  
260

[2] R. Molaei Imenabadi , M. Saremi and W. G. Vandenberghe, " A Novel PNP-Like Z-Shaped Tunnel Field-Effect Transistor With Improved Ambipolar Behavior and RF Performance", *IEEE Transaction on Electron Devices*, vol. 64, issue 11, pp. 4752-4758, 2017. 261  
262  
263  
264

[3] R. Molaei Imenabadi and M. Saremi "A Resonant Tunneling Nanowire Field Effect Transistor with Physical Contractions: A Negative Differential Resistance Device for Low Power Very Large Scale Integration Applications" *Journal of Electronic Materials.*, vol. 47, issue 2, pp. 1091-1098, 2018. 265  
266  
267  
268

[4] V. KhademHosseini, D. Dideban, MT. Ahmadi, and R. Ismail, "Analysis and Modelling of Quantum Capacitance on Graphene Single Electron Transistor" *International Journal of Modern Physics B*, World Scientific Publishing, vol. 32 , issue 22, 1850235, 2018. 269  
270  
271

[5] O. Bitton, D.B. Gutman, R. Berkovits and A. Frydman , " Multiple periodicity in a nanoparticle-based single-electron transistor" *Nature Communications* , vol. 8, 402, 2017. 272  
273

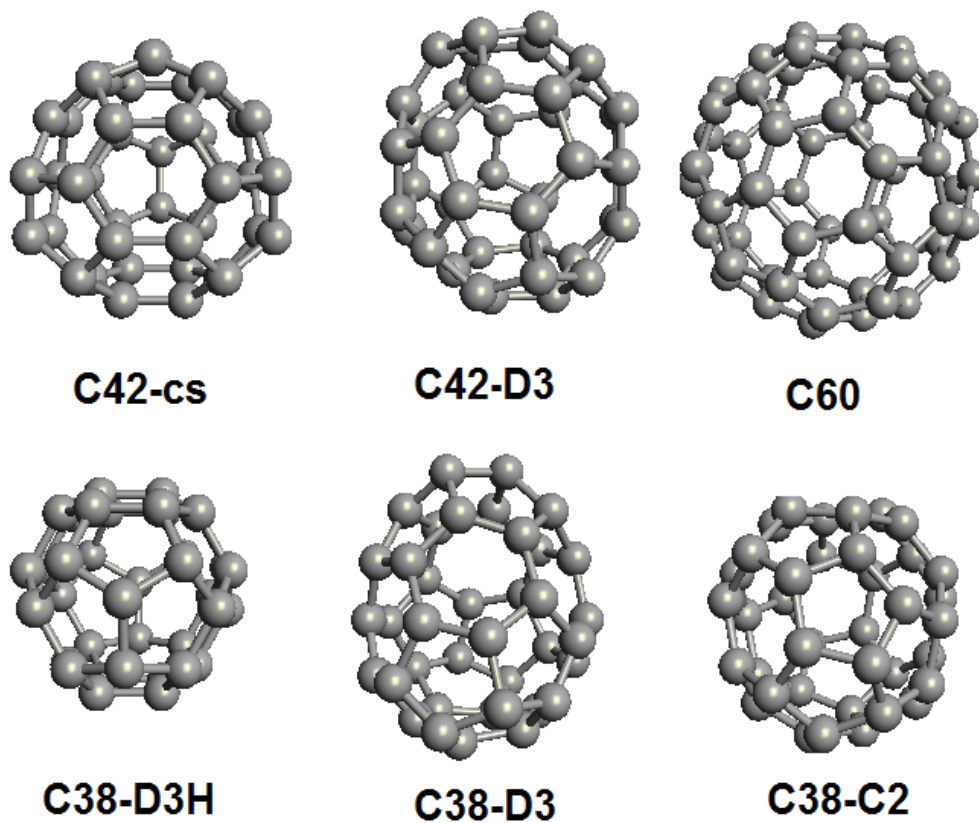
[6] M.J. Sharifi, and M. Ahmadian," Novel designs for digital gates based on single electron devices to overcome the traditional limitation on speed and bit error rate", *Microelectron. J.*,vol. 73, pp. 12-17, 2018. 274  
275  
276

[7] F. Salimian, and D. Dideban , "A Silicene Nanotube Field Effect Transistor (SiNTFET) with an Electrically Induced Gap and High Value of Ion/Ioff" ,*ECS J. Solid State Sci. Technol.* ,vol. 7, no.2,pp.2162-8769,2018. 277  
278  
279

[8] D. Dideban, A. Ketabi, M. Vali, AH. Bayani, and H. Heidari , "Tuning the analog and digital performance of Germanene nanoribbon field effect transistors with engineering the width and geometry of source, channel and drain region in the ballistic regime, *Mater. Sci. Semicond. Process.*, vol. 80, pp. 18-23 , 2018. 280  
281  
282  
283

- [9] M. Yamamoto, Y. Azuma, M. Sakamoto, T. Teranishi, H. Ishii, Y. Majima, and Y. Noguchi, "Molecular floating-gate single-electron transistor", *Nat. Scientific Reports*, vol. 7, 1589, 2017. 284  
285  
286
- [10] AH. Bayani, D. Dideban, M. Vali, and N. Moezi, "Germanene nanoribbon tunneling field effect transistor (GeNR-TFET) with a 10 nm channel length: analog performance, doping and temperature effects", *Semicond. Sci. Technol.* vol.31, no.4, 045009, 2016. 287  
288  
289
- [11] VV. Shorokhov, DE. Presnov, SV. Amitonov, YA .Pashkin and V.A. Krupenin, "Single-electron tunneling through an individual arsenic dopant in silicon", *Nanoscale*, vol.9, pp.613-620, 2017. 290  
291  
292
- [12] V. KhademHosseini, D. Dideban, MT. Ahmadi, and R. Ismail "An analytical approach to model capacitance and resistance of capped carbon nanotube single electron transistor" *Int. J. Electron. Commun. (AEÜ)*, vol.90, pp.97–102, 2018. 293  
294  
295
- [13] F. Wang, J. Fang, Sh. Chang, Sh. Qin, X. Zhang, and H. Xu. "Room temperature Coulomb blockade mediated field emission via self-assembled gold nanoparticles." *Phys. Lett. A*, vol. 381, no.5, pp.476-480, 2017. 296  
297  
298
- [14] C. J. Gorter "A possible explanation of increases in electrical resistance of thin metal films at low temperature and low electric field strength", *Physical*, vol. 17, no.8, pp.777-780, 1951. 299  
300  
301
- [15] E. Sivre, A. Anthore, F. D. Parmentier, A. Cavanna, U. Gennser, A. Ouerghi, Y. Jin, and F. Pierre, "Heat Coulomb blockade of one ballistic channel", *Nat. Phys.*, vol. 14, pp. 145–148, 2018. 302  
303  
304
- [16] V. khademhosseini, M.T.Ahmadi, S.Afrang, and R.Ismail "Analysis of Coulomb blockade in fullerene single electron transistor at room temperature", *J.Nano Analysis*, vol.4, no.2, pp. 120-125, 2017. 305  
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307
- [17] V.KhademHosseini, MT.Ahmadi, S.Afrang, and R. Ismail, "Current analysis and modelling on fullerene single electron transistor at room temperature" *J. Electron. Mater.*, vol.46, no.7, pp.4294-4298, 2017. 308  
309  
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- [18] A. L. Efros, J. B. Delehanty, A.L. Huston, I. L. Medintz, M. Barbic, and T. D. Harris, "Evaluating the potential of using quantum dots for monitoring electrical signals in neurons", *Nat. Nanotechnol.*, vol.13, pp.278–288, 2018. 311  
312  
313

[19] V. Talbo, J. Saint-Martin, S. Retailleau, and P. Dollfus " Non-linear effects and thermoelectric efficiency of quantum dot-based single-electron transistors" nat.Scientific Reports, vol. 7, 14783 ,2017.	314 315 316
[20] V.KhademHosseini, A. K. Jameil,and M T. Ahmadi," analysis of temperature limitation of graphene single electron transistor" Diyala Journal of Engineering Sciences, pp.568-573 ,2015.	317 318 319
[21] V. KhademHosseini, MT. Ahmadi, and R. Ismail" Analysis and Modeling of Fullerene Single Electron Transistor Based on Quantum Dot Arrays at Room Temperature" J. Electron. Mater.,vol.47 , pp .4799–4806,2018.	320 321 322
[22] V. KhademHosseini, D. Dideban, MT. Ahmadi, and R. Ismail, "Analysis of Co-Tunneling Current in Fullerene Single-Electron Transistor", Braz J Phys, vol.48, no.4, pp.406-410, 2018.	323 324 325
[23] V. KhademHosseini, M.T. Ahmadi, S.Afrang, and R.Ismail, " Analysis and Simulation of Coulomb Blockade and Coulomb Diamonds in Fullerene Single Electron Transistors" J. Nanoelectron. optoelectron. , vol.13, pp. 138-143, 2018.	326 327 328
[24] J. Park, A. N.Pasupathy, J. I.Goldsmith, C.Chang, Y.Yaish, J.R. Petta, M.Rinkoski, J.P. Sethna, H. D.Abruña, P. L. McEuen, and D .C.Ralph, " Coulomb blockade and the Kondo effect in single-atom transistors". Nature , vol.417, pp.722-725 , 2002.	329 330 331
[25] A. Allain, , J. Kang, , K. Banerjee , and A. Kis, "Electrical contacts to two-dimensional semiconductors" Nat. Mater., vol. 14, pp.1195–1205 , 2015.	332 333
[26] A.Astefanei,O.Núñez, and M.T. Galcerana, "Characterisation and determination of fullerenes: A critical review",Anal. Chim. Acta, vol. 882, pp. 1-21, 2015.	334 335
[27] <a href="https://quantumwise.com/products">https://quantumwise.com/products</a>	336
[28] E. Ulloa, "Fullerenes and their Applications in Science and Technology" , Introduction to Nanotechnology, Springer, 4138296,2013.	337 338 339
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**Fig.1.** C<sub>38</sub> and C<sub>42</sub> molecules with different types of symmetry and C<sub>60</sub> molecule [23].

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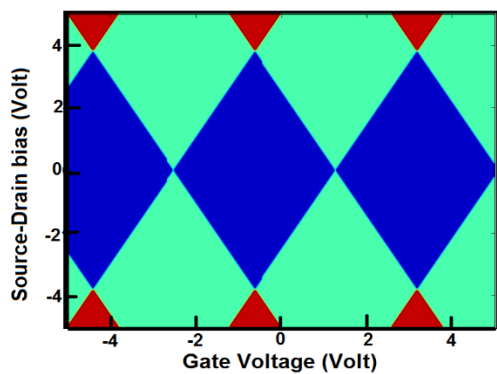
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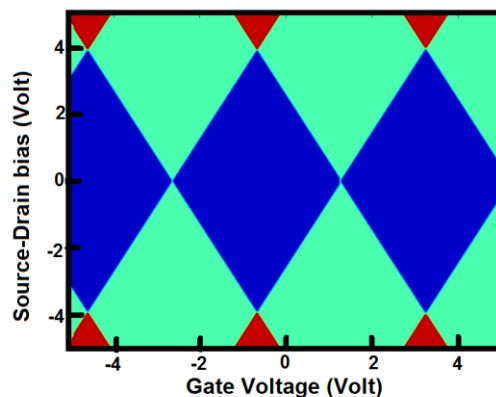
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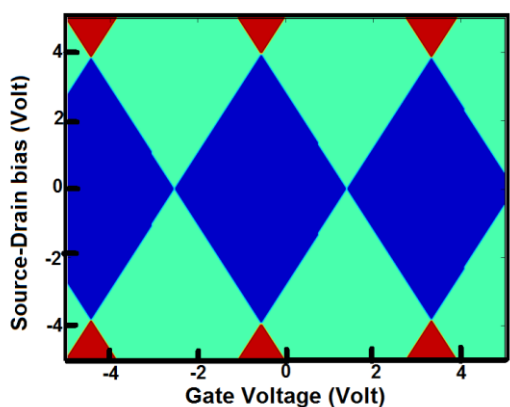
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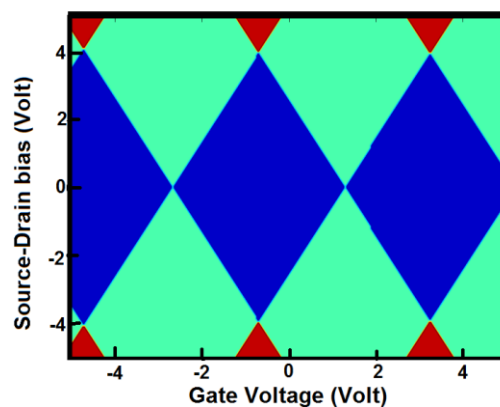
d)  $C_{42}$  molecule -CS



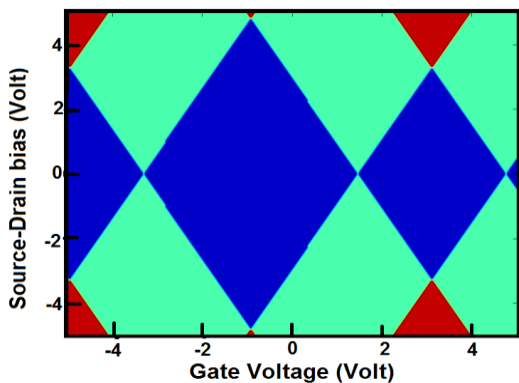
a)  $C_{38}$  molecule - $D_3H$



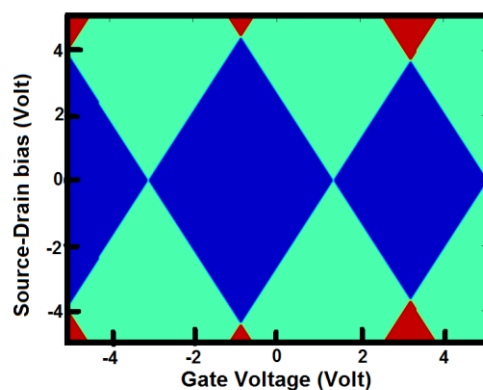
e)  $C_{42}$  molecule - $D_3$



b)  $C_{38}$  molecule - $C_2$

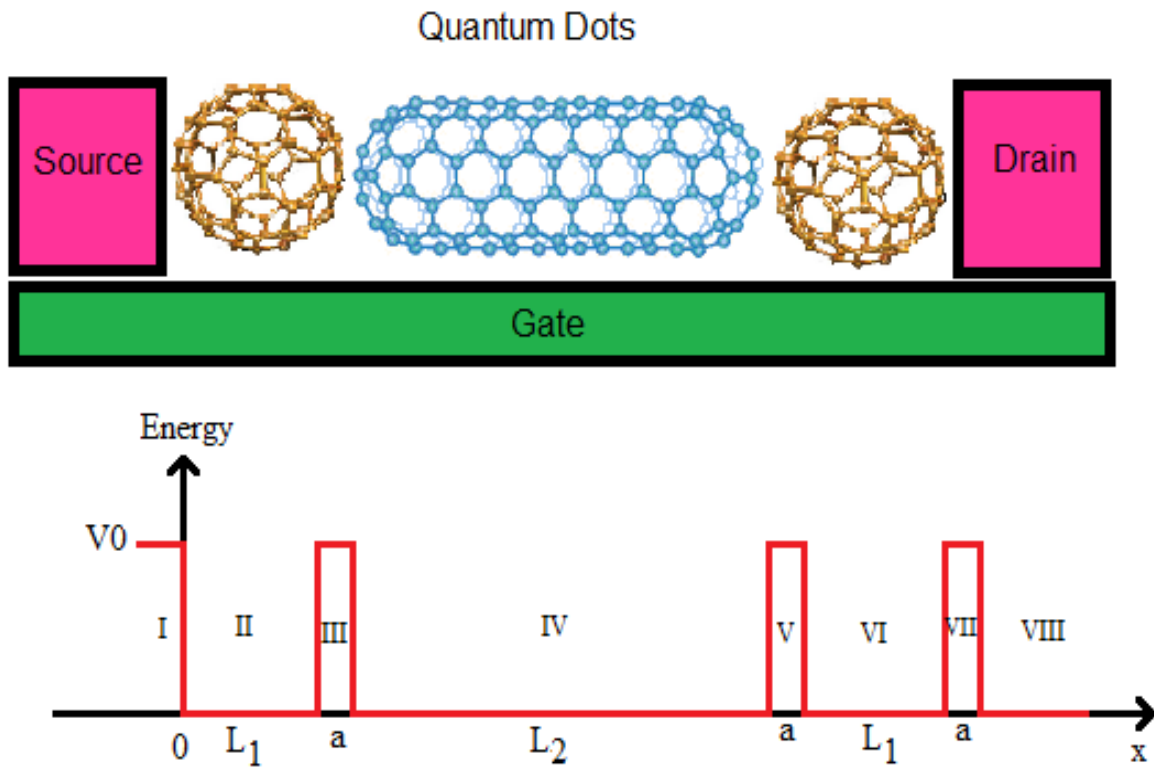


f)  $C_{60}$  molecule



c)  $C_{38}$  molecule - $D_3$

**Fig. 2.** Stability diagrams of  $C_{38}$  and  $C_{42}$  with different types of symmetry and  $C_{60}$ .



**Fig. 3.** Top: SET with three islands (two fullerene molecules in the sides and one carbon nanotube in the middle:  $C_{60} - CNT - C_{60}$ ), Bottom: SET energy versus position in the channel region.

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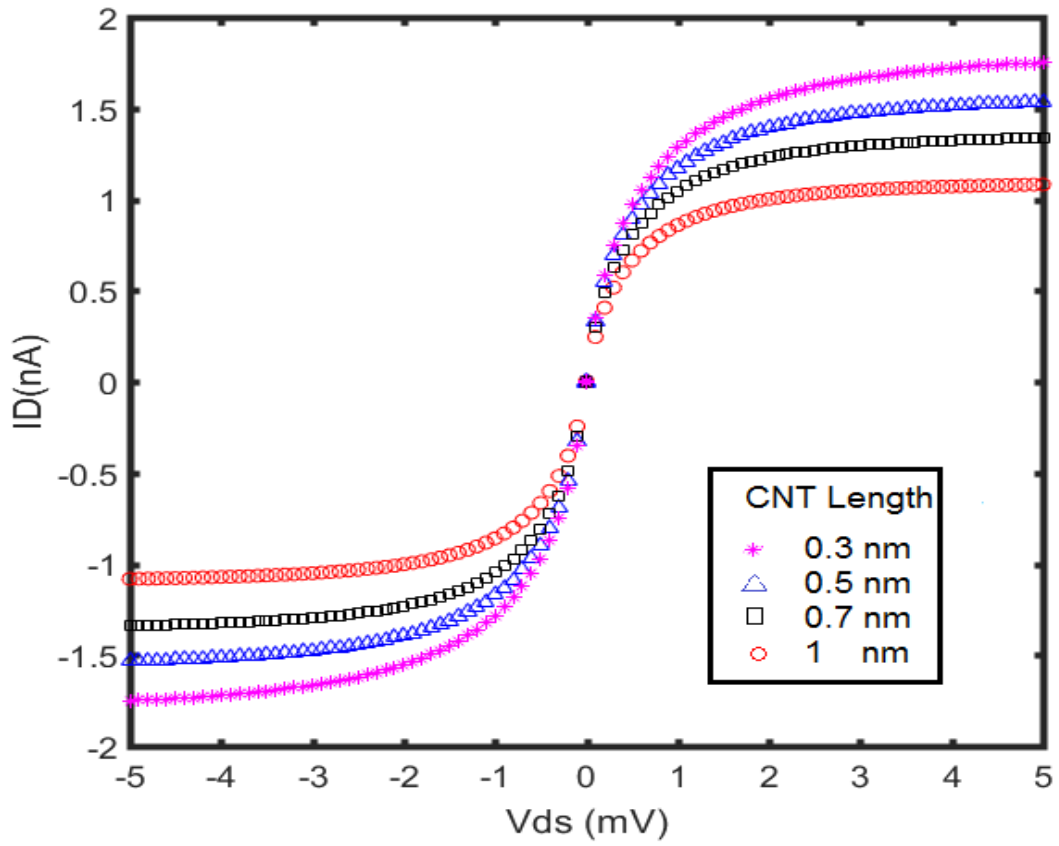
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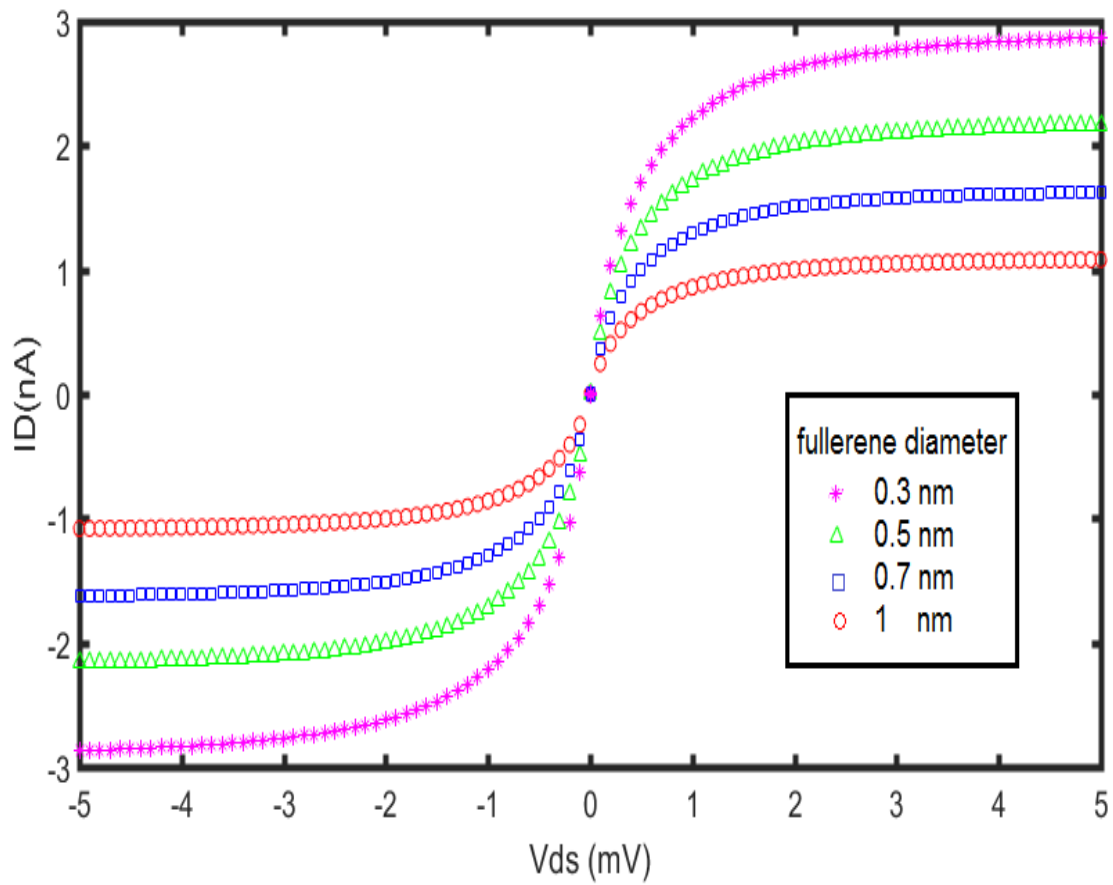
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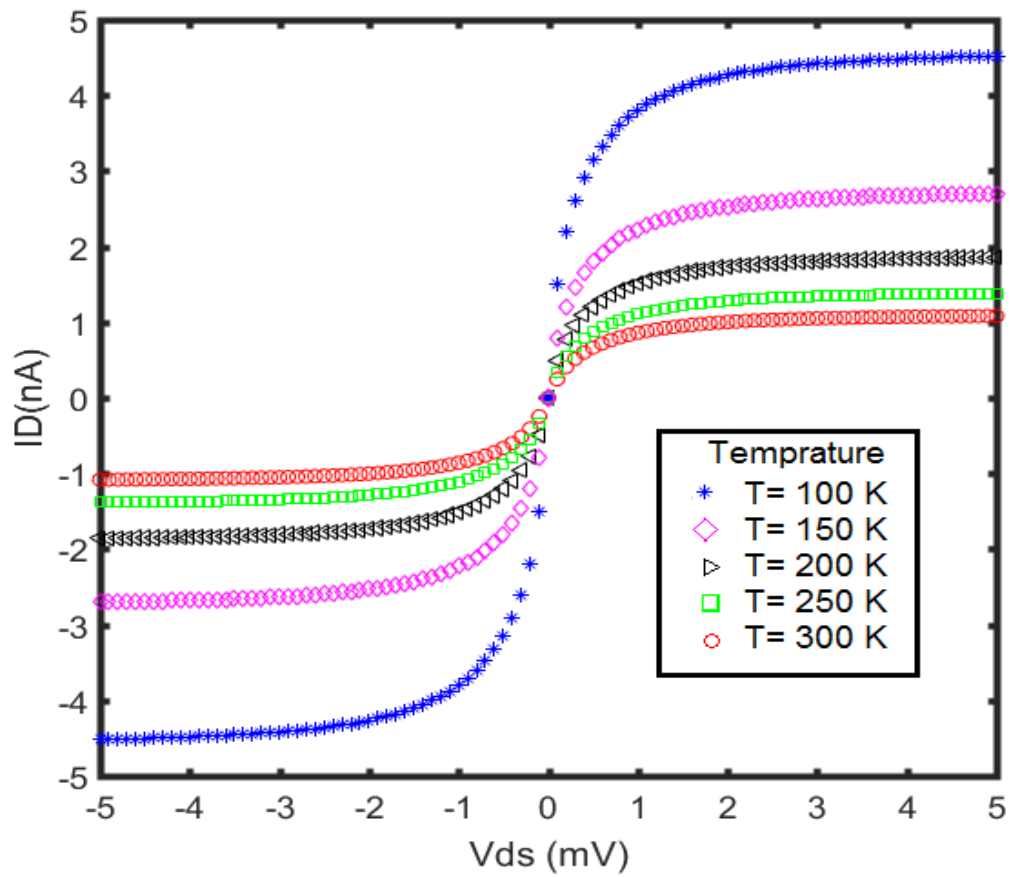


**Fig. 4.** I-V characteristics of the proposed SET ( $C_{60} - CNT - C_{60}$  islands) for different CNT lengths.

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**Fig. 5.** I-V characteristics of the proposed SET ( $C_{60} - CNT - C_{60}$  islands) for different fullerene diameters.



**Fig. 6.** I-V characteristics of the proposed SET ( $C_{60} - CNT - C_{60}$  islands) at different temperatures.

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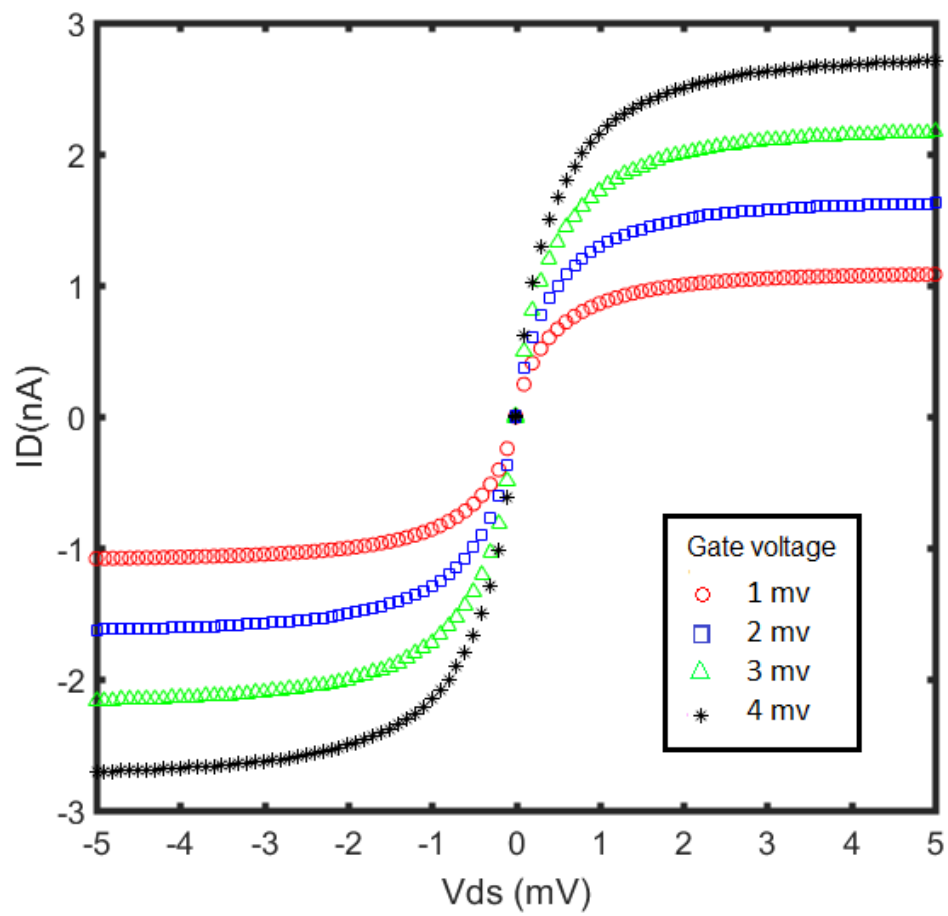
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**Fig. 7.** I-V characteristics of the proposed SET ( $C_{60} - CNT - C_{60}$  islands) for different gate voltages.

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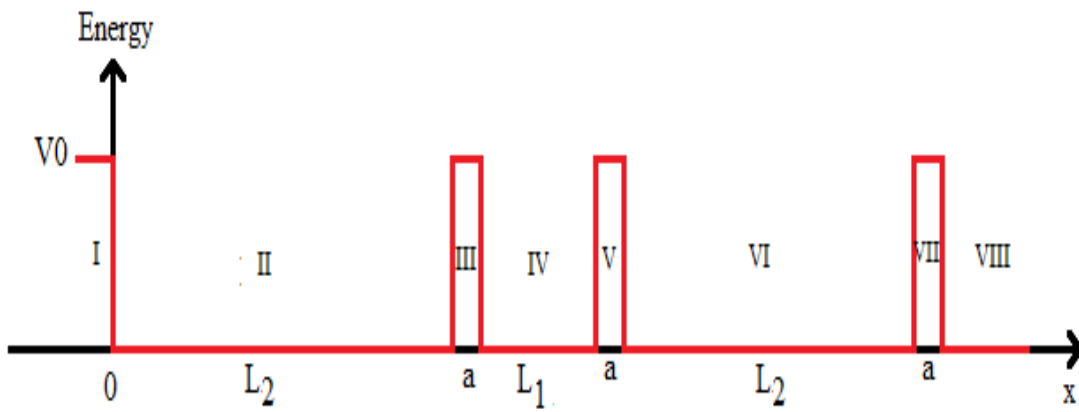
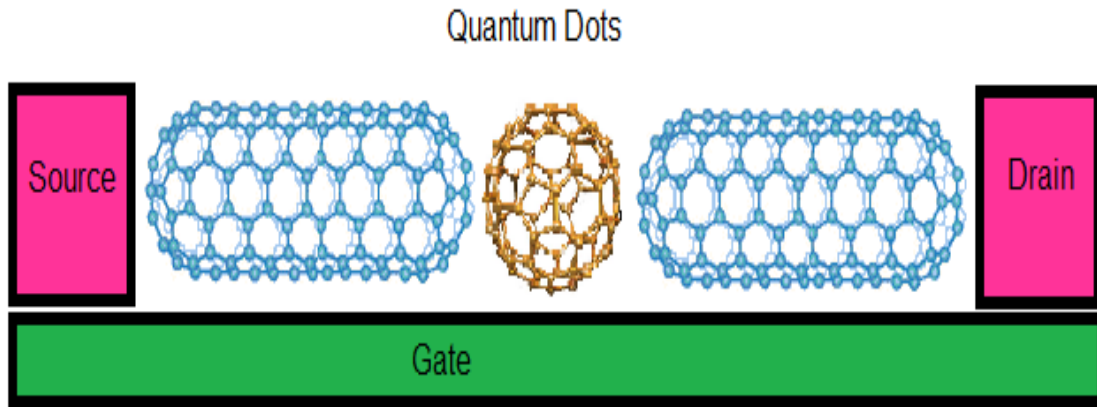
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**Fig.8.** Top: SET with three islands (two CNTs in the sides and one fullerene molecule in the middle:  $CNT - C_{60} - CNT$ ), Bottom: SET energy versus position in the channel region.

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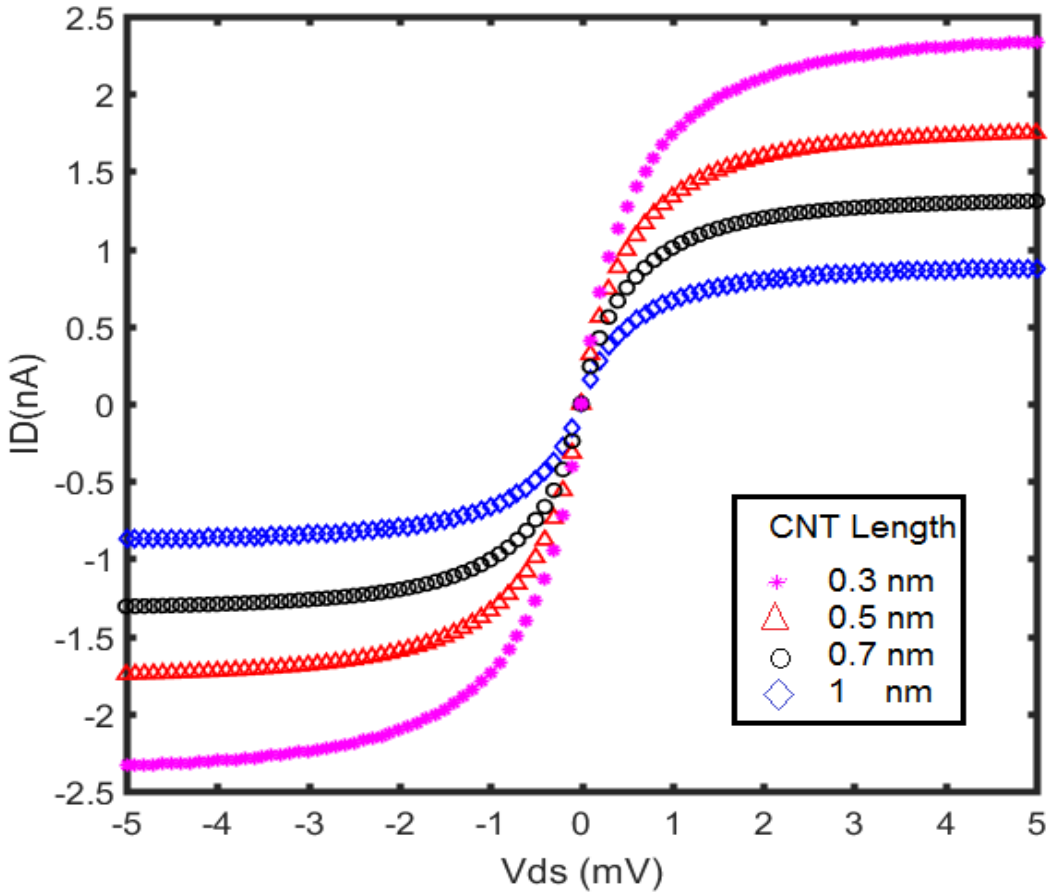
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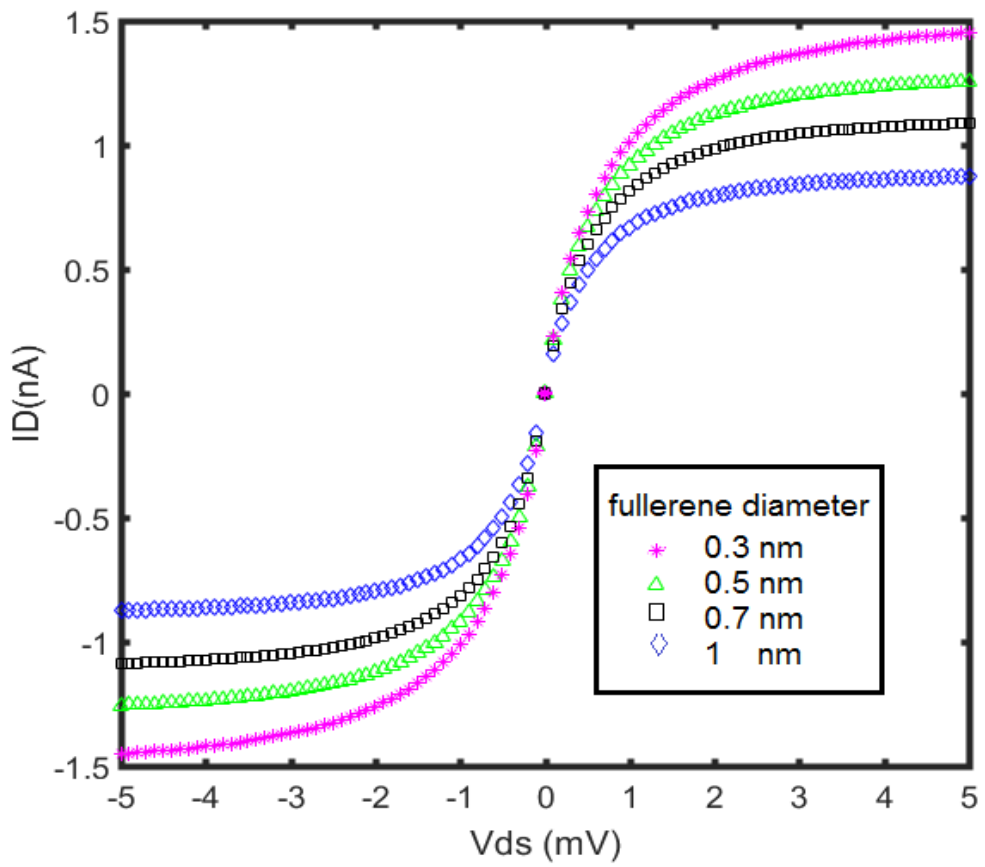
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**Fig. 9.** I-V characteristics of the proposed SET ( $CNT - C_{60} - CNT$  islands) for different CNT lengths.

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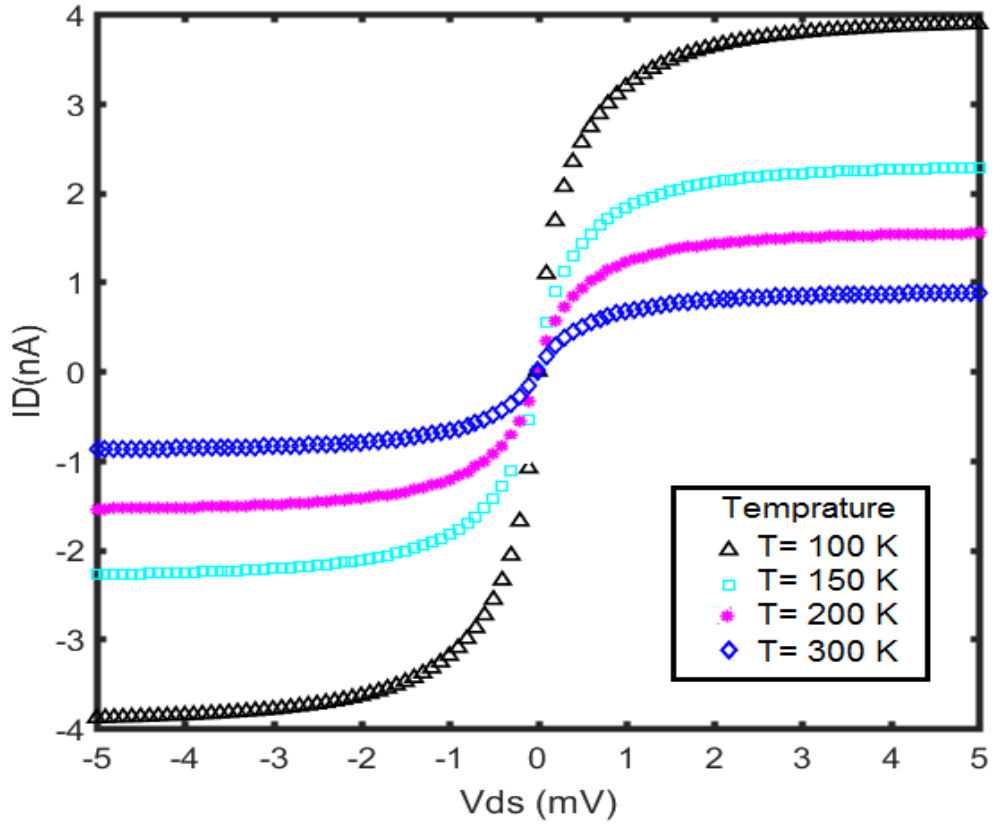
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**Fig. 10.** I-V characteristics of the proposed SET ( $CNT - C_{60} - CNT$  islands) for different fullerene diameters.

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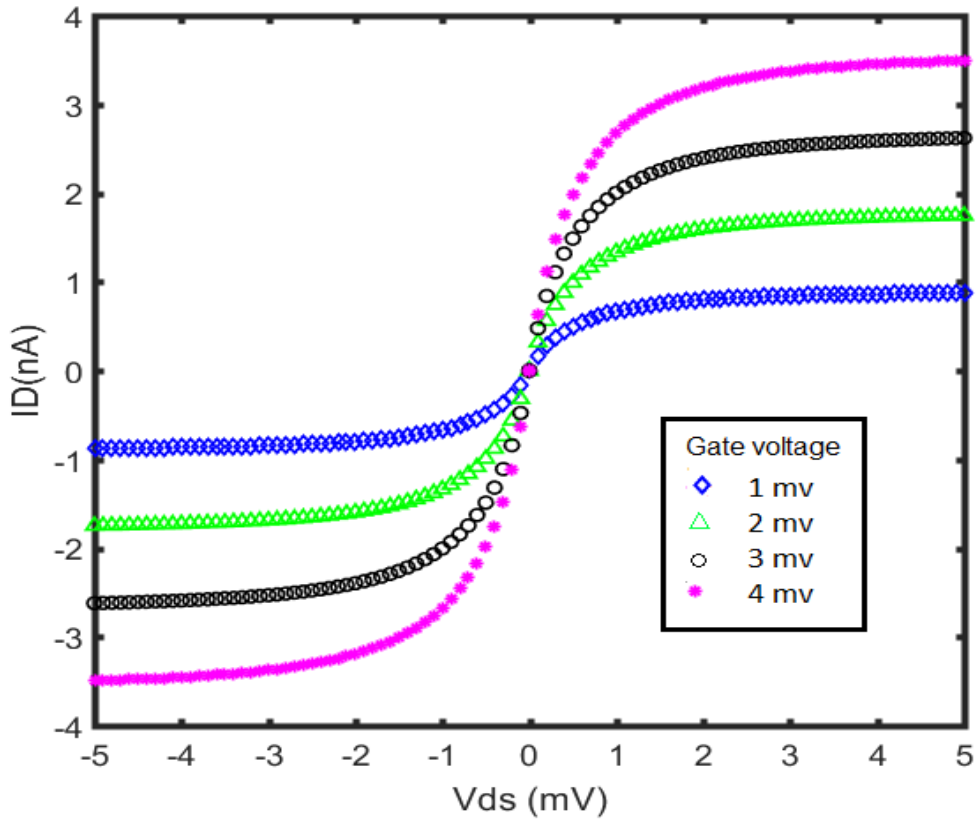
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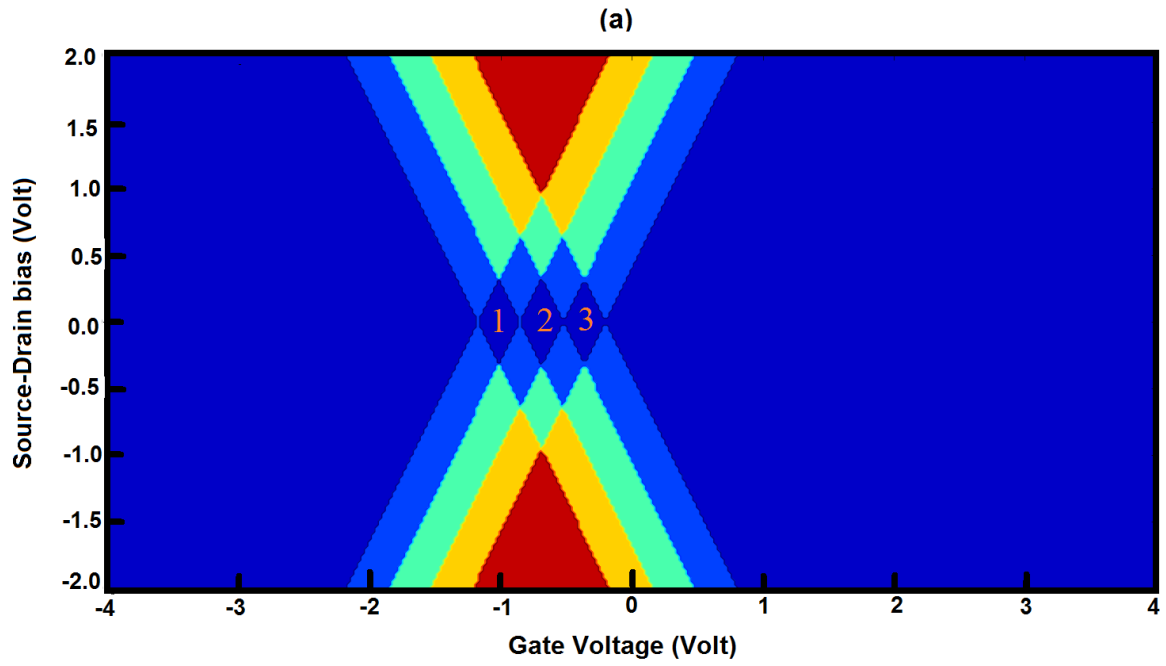
**Fig. 11.** I-V characteristics of the proposed SET ( $CNT - C_{60} - CNT$  islands) at different temperatures.

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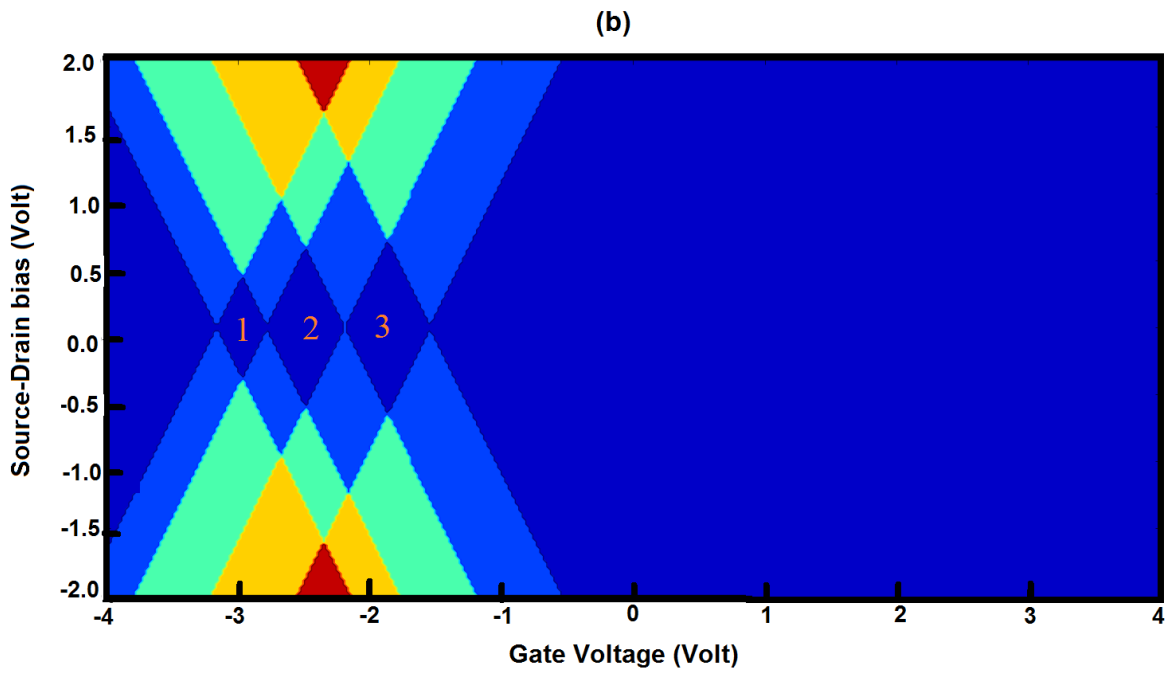




**Fig. 12.** I-V characteristics of the proposed SET ( $CNT - C_{60} - CNT$  islands) for different gate voltages.



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**Fig. 13.** The charge stability diagrams of two proposed SETs with three islands :(a) islands as

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$C_{60} - CNT - C_{60}$ , (b) islands as  $CNT - C_{60} - CNT$ .

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